

<b>Notice of References Cited</b>	Application/Control No. 10/521,891		Applicant(s)/Patent Under Reexamination DORR ET AL.	
	Examiner Anthony Weier		Art Unit 1794	Page 1 of 1

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*	C	US-5,013,576	05-1991	Nakazawa et al.	426/640
*	D	US-2,859,113	11-1958	GOODFRIEND DAVID J	426/590
*	E	US-4,587,119	05-1986	Bucke et al.	424/48
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